

STF11N65M2(045Y)

N-channel 650 V, 0.6 Ω typ., 7 A MDmesh II Plus™ low Q_g Power MOSFET in a TO-220FP package

Datasheet - preliminary data

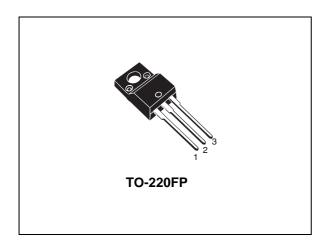
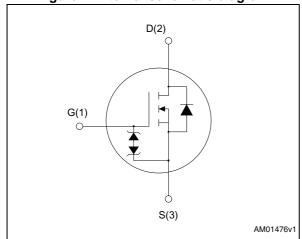


Figure 1. Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max	I _D
STF11N65M2(045Y)	650 V	$0.67~\Omega$	7 A

- Extremely low gate charge
- Lower R_{DS(on)} x area vs previous generation
- · Low gate input resistance
- 100% avalanche tested
- Zener-protected

Applications

· Switching applications

Description

This device is an N-channel Power MOSFET developed using a new generation of MDmesh™ technology: MDmesh II Plus™ low Q_g. This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

Table 1. Device summary

Order code	Marking	Package	Packaging
STF11N65M2(045Y)	11N65M2	TO-220FP	Tube

STF11N65M2(045Y)

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STF11N65M2(045Y) Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 25	V
I _D ⁽¹⁾	Drain current (continuous) at T _c = 25 °C	7	Α
I _D ⁽¹⁾	Drain current (continuous) at T _c = 100 °C	4.4	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	28	Α
P _{TOT} ⁽¹⁾	Total dissipation at T _C = 25 °C	25	W
dv/dt ⁽³⁾	Peak diode recovery voltage slope (starting T _j = 25 °C, I _D = I _{AS} , V _{DD} = 50 V)	15	V/ns
dv/dt ⁽⁴⁾	MOSFET dv/dt ruggedness	50	V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; Tc = 25 °C)	2500	V
T _{stg}	Storage temperature	- 55 to 150	- °C
T _j	Max. operating junction temperature	150	

^{1.} The value is rated according to Rthj-case and limited by package.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	5	°C/W
R _{thj-amb}	Thermal resistance junction-amb max	62.5	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T _{jmax})	1.5	Α
E _{AS}	Single pulse avalanche energy (starting T_j =25°C, I_D = I_{AR} ; V_{DD} =50)	110	mJ

^{2.} Pulse width limited by T_{jmax}

^{3.} $I_{SD} \le 7$ A, di/dt ≤ 400 A/ μ s; $V_{DS peak} < V_{(BR)DSS}$, V_{DD} =80% $V_{(BR)DSS}$.

^{4.} $V_{DS} \le 520 \text{ V}$

Electrical characteristics STF11N65M2(045Y)

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage (V _{GS} = 0)	I _D = 1 mA	650			V
1	Zero gate voltage	V _{DS} = 650 V			1	μΑ
IDSS	drain current (V _{GS} = 0)	V _{DS} = 650 V, T _C =125 °C			100	μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2	3	4	٧
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 3.5 A		0.6	0.67	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	410	-	pF
C _{oss}	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	20	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	0.95	-	pF
C _{oss eq.} ⁽¹⁾	Equivalent output capacitance	V _{DS} = 0 to 520 V, V _{GS} = 0	-	83	-	pF
R_{G}	Intrinsic gate resistance	f = 1 MHz open drain	-	6.4	-	Ω
Qg	Total gate charge		-	12.5	-	nC
Q _{gs}	Gate-source charge	V _{DD} = 520 V, I _D = 7 A, V _{GS} = 10 V (see <i>Figure 15</i>)	-	3.2	-	nC
Q_{gd}	Gate-drain charge	143 10 1 (000 / 194/0 / 10)	-	5.8	-	nC

^{1.} $C_{\rm oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as $C_{\rm oss}$ when $V_{\rm DS}$ increases from 0 to 80% $V_{\rm DSS}$

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	9.5	-	ns
t _r	Rise time	$V_{DD} = 325 \text{ V}, I_{D} = 3.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 14</i> and <i>19</i>)	-	7.5	-	ns
t _{d(off)}	Turn-off delay time		-	26	-	ns
t _f	Fall time		-	15	-	ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		7	Α
I _{SDM} ^{(1) (2)}	Source-drain current (pulsed)		-		28	Α
V _{SD} (3)	Forward on voltage	I _{SD} = 7 A, V _{GS} = 0	-		1.6	٧
t _{rr}	Reverse recovery time	7.4 (2) 11/11 400.4/	-	318		ns
Q_{rr}	Reverse recovery charge	$I_{SD} = 7 \text{ A}^{(2)}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 60 \text{ V} \text{ (see } Figure 16\text{)}$	-	2.5		nC
I _{RRM}	Reverse recovery current	TDD co i (coo i igailo ilo)	-	15.5		Α
t _{rr}	Reverse recovery time	I _{SD} = 7 A, di/dt = 100 A/μs	ı	437		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V, T _i =150 °C	-	3.2		nC
I _{RRM}	Reverse recovery current	(see Figure 16)	ı	15		Α

^{1.} Pulse width limited by safe operating area

^{2.} Test condition is referred to through-hole package

^{3.} Pulsed: pulse duration = 300μ s, duty cycle 1.5%

Electrical characteristics STF11N65M2(045Y)

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

ID GIPG200120141643FSR
(A) 10 μs 100μs 100μs 100ms

Figure 3. Thermal impedance

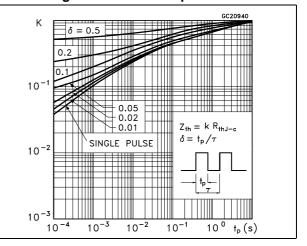


Figure 4. Output characteristics

Tc=150°C Tamb=25°C

100

VDS(V)

ID GIPD241020131645FSR
(A) VGS= 8, 9, 10V

14

12

10

6V

8

6

4

2

0

5V

20

VDS(V)

Figure 5. Transfer characteristics

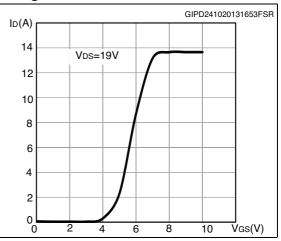


Figure 6. Normalized $V_{(BR)DSS}$ vs temperature

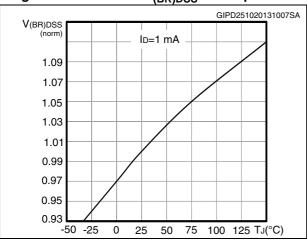
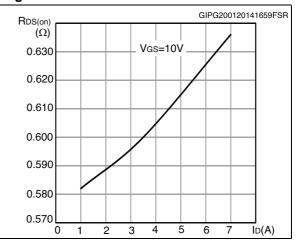


Figure 7. Static drain-source on-resistance



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STF11N65M2(045Y) Electrical characteristics

Figure 8. Gate charge vs gate-source voltage

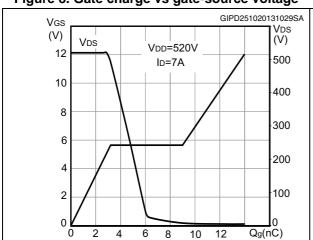


Figure 9. Capacitance variations

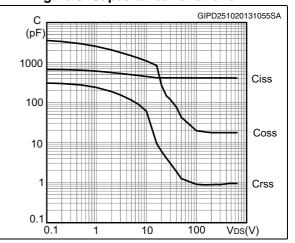
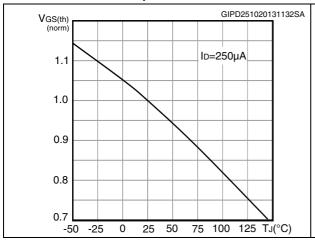


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



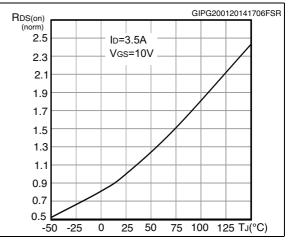
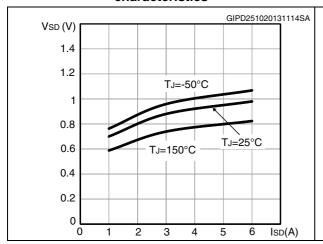
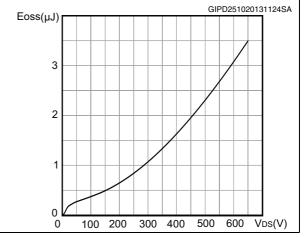


Figure 12. Source-drain diode forward characteristics

Figure 13. Output capacitance stored energy





Test circuits STF11N65M2(045Y)

3 Test circuits

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

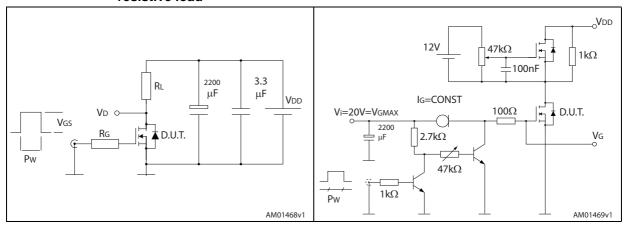


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

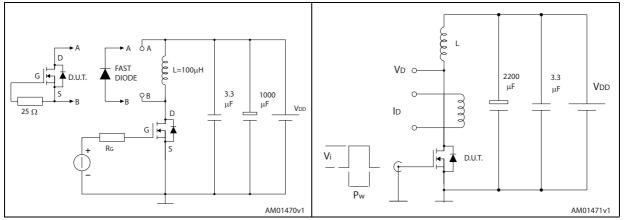
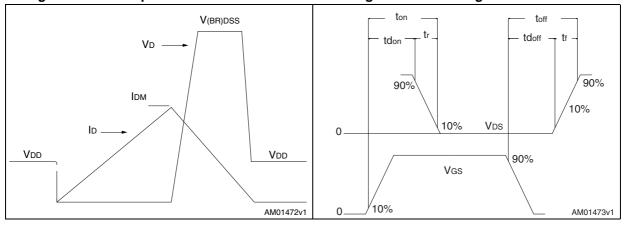


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



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4 Package mechanical data

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-*B*-Dia L6 L2 *L7* L3 F1 **L4** F2 Ε -G1-7012510_Rev_K_B

Figure 20. TO-220FP drawing

Table 9. TO-220FP mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.4		4.6
В	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Ø	3		3.2



Revision history STF11N65M2(045Y)

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
09-May-2014	1	First release.

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